

STD40NF3LL

N-channel 30V - 0.009Ω - 40A - DPAK Low gate charge STripFET™ II Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STD40NF3LL	30V	<0.011Ω	40A

- Logic level device
- Optimal R_{DS(on)} x Q_q trade-off
- Conduction losses reduced
- Switching losses reduced
- Low threshold drive

Description

This application specific Power MOSFET is the third generation of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows the best trade-off between on-resistance and gate charge. When used as high and low side in buck regulators, it gives the best performance in terms of both conduction and switching losses. This is extremely important for motherboards where fast switching and high efficiency are of paramount importance.

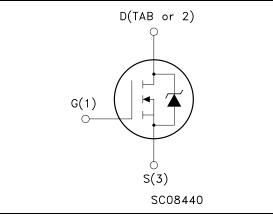
Applications

Switching application

Order codes

DPAK	
DIAN	

Internal schematic diagram



Part number	Marking	Package	Packaging
STD40NF3LLT4	D40NF3LL@	DPAK	Tape & reel

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Electrical ratings

Table 1.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage ($V_{GS} = 0$)	30	V
V _{DGR}	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	30	V
V _{GS}	Gate- source voltage	± 16	V
Ι _D ⁽¹⁾	Drain current (continuous) at $T_C = 25^{\circ}C$	40	A
I _D	Drain current (continuous) at T _C = 100°C	28	A
I _{DM} ⁽²⁾	Drain current (pulsed)	160	A
P _{tot}	Total dissipation at $T_C = 25^{\circ}C$	80	W
	Derating Factor	0.53	W/°C
dv/dt ⁽³⁾	Peak diode recovery voltage slope	5.5	V/ns
E _{AS} ⁽⁴⁾	Single pulse avalanche energy	850	mJ
T _{stg}	Storage temperature	-55 to 175	°C
Тj	Max. operating junction temperature	55 10 175	C

1. Current limited by package

2. Pulse width limited by safe operating area.

3. I_{SD} \leq 0A, di/dt \leq 50A/ μ s, V_{DD} \leq V_{(BR)DSS}, T_j \leq T_{JMAX}

4. Starting $T_j = 25 \text{ °C}$, $I_D = 20A$, $V_{DD} = 25V$

Table 2. T	Thermal	data
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Rthj-case	Thermal resistance junction-case max	1.88	°C/W
Rthj-amb	Thermal resistance junction-ambient max	100	°C/W
TJ	Maximum lead temperature for soldering purpose	300	°C



2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 5.	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 250 \mu A, V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V_{DS} = max rating V_{DS} = max rating, T_{C} = 125°C			1 10	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	$V_{GS} = \pm 16V$			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, \ I_D = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 20A$ $V_{GS} = 4.5V, I_D = 10A$		0.0090 0.0115	0.0110 0.0135	Ω Ω

Table 3. On/off states

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 15V _, I _D = 20A		23		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1MHz, V _{GS} = 0		1650 540 130		pF pF pF
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 15V, I_D = 20A$ $R_G = 4.7\Omega V_{GS} = 4.5V$ (see <i>Figure 13</i>)		23 156 27 28		ns ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$\label{eq:VD} \begin{split} V_{DD} &= 15 \text{V}, \ \text{I}_D = 20 \text{A}, \\ V_{GS} &= 4.5 \text{V}, \ \text{R}_G = 4.7 \Omega \\ (\text{see Figure 14}) \end{split}$		24 8.5 12	33	nC nC nC

1. Pulsed: Pulse duration = $300 \ \mu s$, duty cycle 1.5%.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				40 160	A A
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 40A, V_{GS} = 0$			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 40A, di/dt = 100A/μs, V _{DD} = 15V, T _j = 150°C (see <i>Figure 15</i>)		40 50 2.5		ns nC A

Table 5.Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

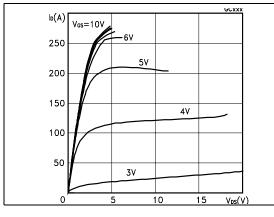


2.1 Electrical characteristics (curves)

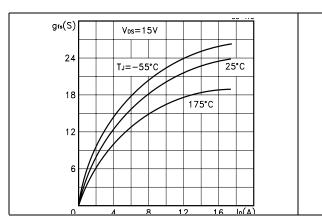
Figure 1. Safe operating area

lo(A) 4 10² X 100µs 1ms 10¹ 10ms OPERATION 10⁰ ⁶ ⁸ 10⁰ 2 ⁶⁸10¹ 6 8 VDS(V) 10^{-1}











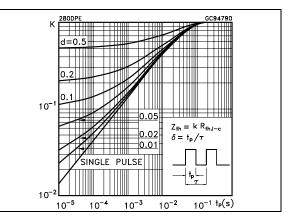


Figure 4. Transfer characteristics

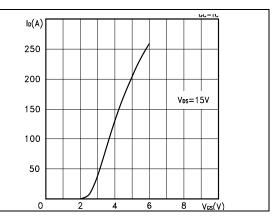
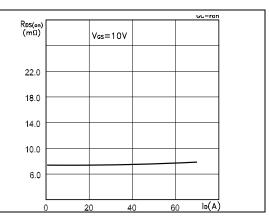


Figure 6. Static drain-source on resistance



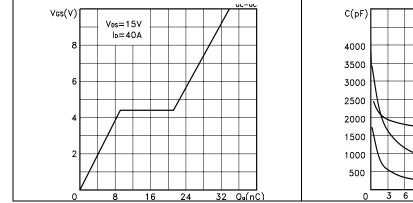
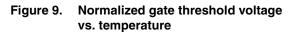


Figure 7. Gate charge vs. gate-source voltage Figure 8. Capacitance variations



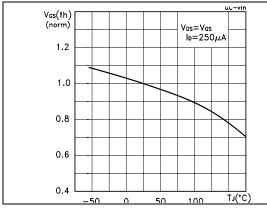


Figure 11. Source-drain diode forward characteristics

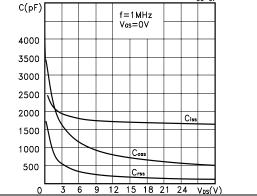


Figure 10. Normalized on resistance vs. temperature

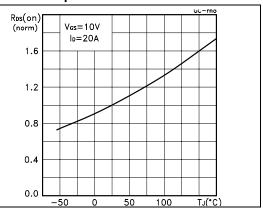
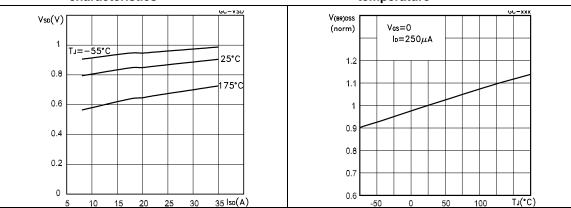


Figure 12. Normalized breakdown voltage vs. temperature



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VDD

1ΚΩ

3 **Test circuit**

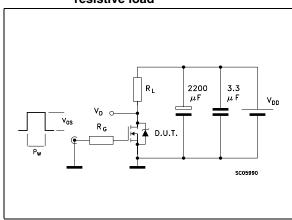
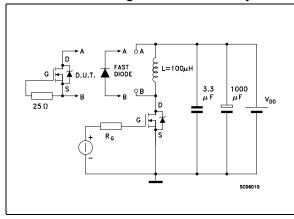
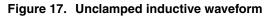


Figure 15. Test circuit for inductive load switching and diode recovery times

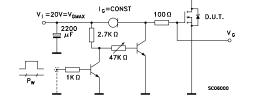




I_G=CONST V1=20V=VGMAX **100 Ω**

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Figure 14. Gate charge test circuit



‡7K Ω

±100nF

Figure 16. Unclamped Inductive load test circuit

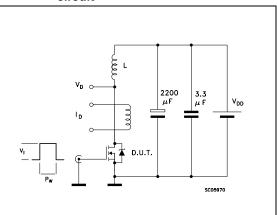
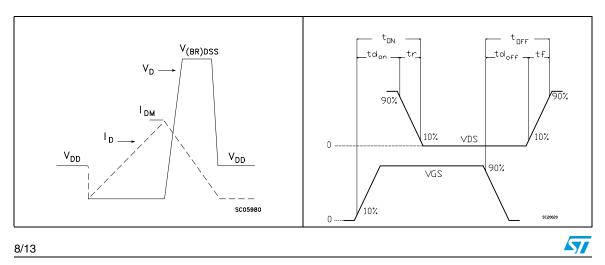


Figure 18. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



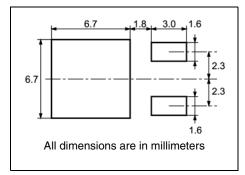
DIM		mm.			inch	
DIM.	MIN.	ТҮР	MAX.	MIN.	TYP.	MAX
А	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
E	6.4		6.6	0.252		0.260
E1		4.7			0.185	
е		2.28			0.090	
e1	4.4		4.6	0.173		0.181
Н	9.35		10.1	0.368		0.397
L	1			0.039		
(L1)		2.8			0.110	
L2		0.8			0.031	
L4	0.6		1	0.023		0.039
R		0.2			0.008	
V2	0°		8°	0°		8°
	ſ		c2 /	THERMAL D1		
	H			R	ц Ц	

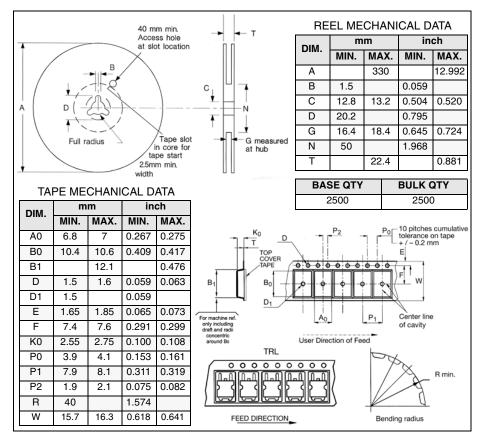
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5 Packing mechanical data

DPAK FOOTPRINT





TAPE AND REEL SHIPMENT

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6 Revision history

Table 6. Revision history

Date	Revision	Changes
21-Jun-2004	3	New datasheet according to PCN DSG/CT/2C13 marking:D40NF3LL@
11-Jul-2006	4	New template, no content change
20-Feb-2007	5	Typo mistake on page 1

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